

## CoolSiC™ 400V CoolSiC™ G2 MOSFET

### **Features**

- Ideal for high frequency switching and synchronous rectification
- Commutation robust fast body diode with low Q<sub>fr</sub>
- Low R<sub>DS(on)</sub> dependency on temperature
   Benchmark gate threshold voltage, V<sub>GS(th)</sub> = 4.5 V
   Recommended gate driving voltage 0 V to 18 V
- .XT interconnection technology for best-in-class thermal performance
- · 100% avalanche tested

## Potential applications

- SMPS
- Solar PV inverters
- Energy storage, UPS and battery formation
- Class-D audio
- Motor drives

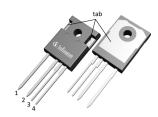
### **Product validation**

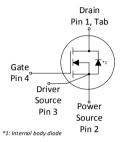
Qualified for industrial applications according to the relevant tests of JEDEC JESD47, JESD22 and J-STD-020.

Table 1 Key performance parameters

Parameter	Value	Unit
$V_{\mathrm{DS}}$	400	V
$R_{\mathrm{DS(on),typ}}$	36.5	mΩ
$I_{D}$	46	А
$Q_{\rm oss}$	42	nC
E <sub>oss</sub>	3.0	μЈ
$Q_{G}$	26	nC

#### PG-T0247-4







Part number	Package	Marking	Related links
IMZA40R036M2H	PG-TO247-4	40R036M2	-

### **Public**

# 400V CoolSiC™ G2 MOSFET IMZA40R036M2H



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## 1 Maximum ratings

at  $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol		Values			Note / Test condition	
Parameter	Syllibol	Min.	Тур.	Max.		Note / Test condition	
Continuous drain current 1)	,			46	Α	$V_{\rm GS}$ =18 V, $T_{\rm C}$ =25 °C	
Continuous drain current	I <sub>D</sub>	_	_	33	A	V <sub>GS</sub> =18 V, T <sub>C</sub> =100 °C	
Pulsed drain current <sup>2)</sup>	$I_{\rm D,pulse}$	-	-	138	А	<i>T</i> <sub>C</sub> =25 °C	
Avalanche energy, single pulse 3)	E <sub>AS</sub>			66	ml	$I_{\rm D}$ =11.1 A, $R_{\rm GS}$ =25 $\Omega$	
Avalanche energy, repetitive	E <sub>AR</sub>			0.33	1113	1 <sub>D</sub> -11.1 A, N <sub>GS</sub> -25 12	
Gate source voltage (static)	$V_{\rm GS,DC}$	-7	-	23	V	-	
Gate source voltage (transient)	$V_{\rm GS,AC}$	-10	-	25	V	t <sub>pulse</sub> ≤500 ns, duty cycle≤1%	
Power dissipation	$P_{\text{tot}}$	-	-	139	W	<i>T</i> <sub>c</sub> =25 °C	
Storage temperature	$T_{\rm stg}$	55		150	°C		
Operating junction temperature	T <sub>j</sub>	-55	-	175		<del>-</del> 	

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

<sup>2)</sup> See Diagram 3 for more detailed information.

<sup>3)</sup> See Diagram 19 for more detailed information.



## 2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol		Values		Unit	Note / Test condition	
raiametei	Symbol	Min.	Тур.	Max.	Oille	Note / Test condition	
Thermal resistance, junction - case	$R_{thJC}$	-	-	1.08	°C/W	-	

## 3 Operating range

## Table 4 Operating range

Parameter	Symbol		Values		Linit	Note / Test condition	
raianietei	Syllibot	Min. Typ.		Max.	Oille	Note / Test condition	
Recommended turn-on voltage	$V_{\rm GS(on)}$		18		W		
Recommended turn-off voltage	$V_{\rm GS(off)}$	-	0		V	-	



## 4 Electrical characteristics

at  $T_i$ =25 °C, unless otherwise specified

Table 5 Static characteristics

Darameter	Symbol		Values			Nieto / Test som dition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test condition	
Drain-source breakdown voltage	$V_{(BR)DSS}$	400	-	-	V	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =0.4 mA	
Gate threshold voltage <sup>4)</sup>	$V_{\rm GS(th)}$	3.5	4.5	5.6	٧	$V_{\rm DS} = V_{\rm GS}$ , $I_{\rm D} = 4$ mA	
Zoro gato voltago drain current	1	-	1	75		V <sub>DS</sub> =400 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	
Zero gate voltage drain current	I <sub>DSS</sub>		2	-	μΑ	$V_{DS}$ =400 V, $V_{GS}$ =0 V, $T_j$ =25 °C $V_{DS}$ =400 V, $V_{GS}$ =0 V, $T_j$ =175 °C	
Gate-source leakage current	$I_{GSS}$	-	1	100	nA	$V_{GS}$ =20 V, $V_{DS}$ =0 V	
			36.5	45.7		$V_{\rm GS}$ =18 V, $I_{\rm D}$ =11.1 A, $T_{\rm j}$ =25 °C	
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	-	52.4	-	mΩ	$V_{GS}$ =18 V, $I_D$ =11.1 A, $T_j$ =175 °C	
			44.6	-		$V_{\rm GS}$ =15 V, $I_{\rm D}$ =11.1 A, $T_{\rm j}$ =25 °C	
Gate resistance	$R_{G}$	-	5.5	-	Ω	-	

<sup>4)</sup> Tested after 1ms pulse at  $V_{GS}$  = +20V.

Table 6 Dynamic characteristics

Parameter	Symbol		Values		Linit	Note / Test condition	
Parameter	Symbol	Min.	Тур.	Max.			
Input capacitance	C <sub>iss</sub>		870				
Output capacitance	$C_{\rm oss}$	]-	120	-	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =200 V, <i>f</i> =1 MHz	
Reverse transfer capacitance	C <sub>rss</sub>		10				
Effective output capacitance, energy related <sup>5)</sup>	$C_{o(er)}$	-	150	-	рF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =0200 V	
Effective output capacitance, time related <sup>6)</sup>	$C_{\rm o(tr)}$	-	210	-	pF	$I_{\rm D}$ =constant, $V_{\rm GS}$ =0 V, $V_{\rm DS}$ =0200 V	
Turn-on delay time <sup>7)</sup>	$t_{\sf d(on)}$		7.4			$V_{\rm DD}$ =200 V, $V_{\rm GS}$ =018 V, $I_{\rm D}$ =11.1 A,	
Rise time <sup>7)</sup>	t <sub>r</sub>	- 7.4 -		-		$R_{\rm G,ext}$ =1.8 $\Omega$	
Turn-off delay time <sup>7)</sup>	$t_{\sf d(off)}$		18.7		nc	V <sub>DD</sub> =200 V, V <sub>GS</sub> =180 V, I <sub>D</sub> =11.1 A,	
Fall time <sup>7)</sup>	$t_{\rm f}$	]	6.5	]-	ns	$R_{G,ext}$ =1.8 $\Omega$	

<sup>&</sup>lt;sup>5)</sup>  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 200 V.

<sup>&</sup>lt;sup>6)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 200 V.

<sup>7)</sup> Refer to Table 9 for test setup.



Table 7 Gate Charge Characteristics 8)

Parameter	Symbol	Values			Linit	Note / Test condition	
raiailletei	Symbol	Min.	Тур.	Max.		Note / Test condition	
Gate to source charge	$Q_{\mathrm{gs}}$		7				
Gate to drain charge	$Q_{\mathrm{gd}}$	]-	5.4	-	nC	$V_{\rm DD}$ =200 V, $I_{\rm D}$ =11.1 A, $V_{\rm GS}$ =0 to 18 V	
Gate charge total	$Q_{ m g}$		26				
Gate charge total, sync. FET	$Q_{\rm g(sync)}$	-	24	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 18 V	
Output charge	$Q_{\rm oss}$		42		nC	1/ -200 //	
Output Energy	E <sub>oss</sub>		3.0	]-	μJ	$V_{\rm DS}$ =200 V, $V_{\rm GS}$ =0 V	

 $<sup>^{8)}</sup>$   $\,$  As per JEP192, Guidelines for Gate Charge (  $Q_{\rm G}$  ) Test Method for SiC MOSFET.

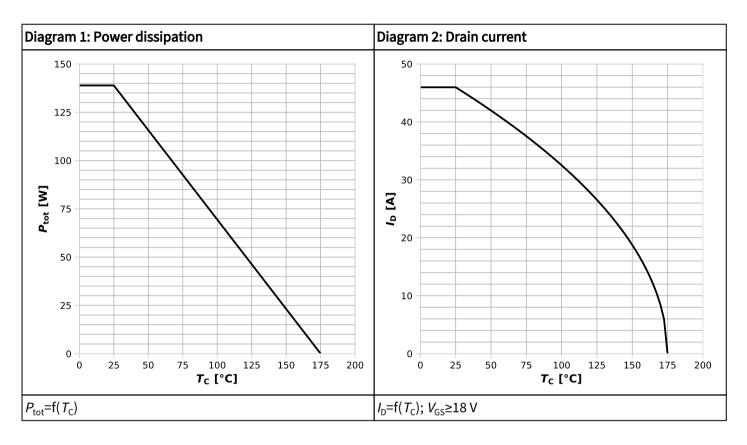
Table 8 Reverse diode characteristics

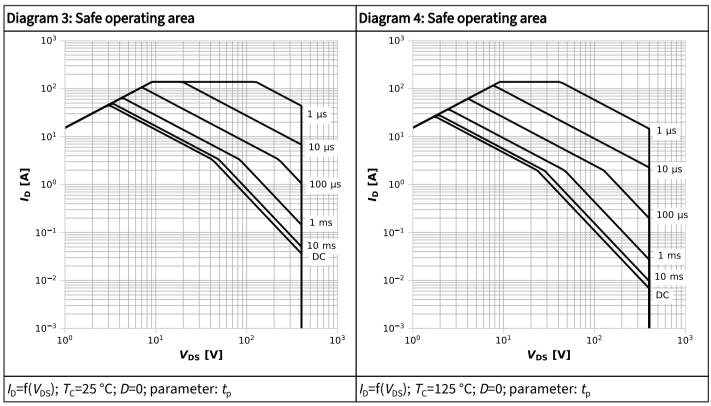
Devematev	Symphol	Values			115:4	Nata / Tast as a dition	
Parameter	Symbol	Min.	Min. Typ. Max.		Unit	Note / Test condition	
Diode continuous forward current	I <sub>S</sub>	-	-	21	Α	<i>T</i> <sub>C</sub> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	138	Α	$T_{\rm C}$ =25 °C, $t_{\rm pulse}$ ≤250 ns	
Diode forward voltage	$V_{SD}$	-	3.5	4.3	V	$V_{\rm GS}$ =0 V, $I_{\rm S}$ =11.1 A, $T_{\rm j}$ =25 °C	
MOCETT (	t <sub>fr</sub>	-	11.2		ns	$V_{\rm R}$ =200 V, $I_{\rm S}$ =11.1 A, d $i_{\rm S}$ /d $t$ =1000 A/ $\mu$ s	
MOSFET forward recovery time			10.2			$V_{\rm R}$ =200 V, $I_{\rm S}$ =11.1 A, d $i_{\rm S}$ /d $t$ =3000 A/ $\mu$ s	
MOSTET for word recovery above 9)		-	49.3	-	nC	$V_{\rm R}$ =200 V, $I_{\rm S}$ =11.1 A, d $i_{\rm S}$ /d $t$ =1000 A/ $\mu$ s	
MOSFET forward recovery charge <sup>9)</sup>	$Q_{\mathrm{fr}}$		115.7		i iiC	$V_{\rm R}$ =200 V, $I_{\rm S}$ =11.1 A, d $i_{\rm S}$ /d $t$ =3000 A/ $\mu$ s	

 $<sup>^{9)}~~</sup>Q_{\rm fr}$  includes  $Q_{\rm oss}.$  Refer to Table 10 for test setup.

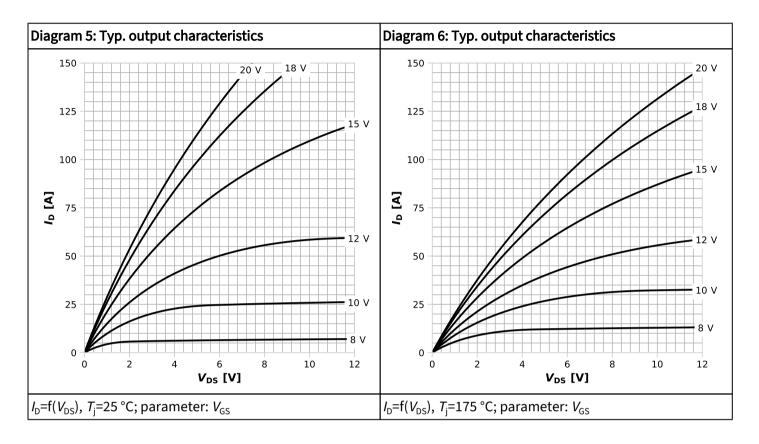


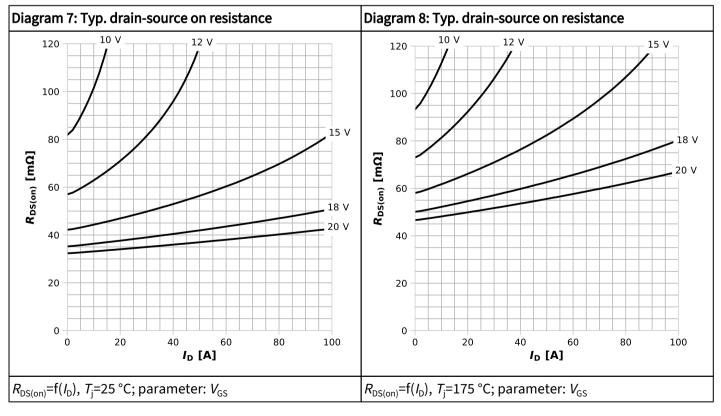
## 5 Electrical characteristics diagrams



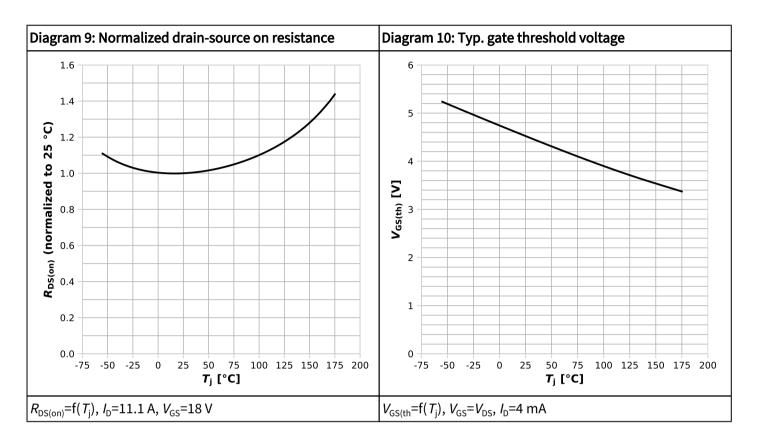


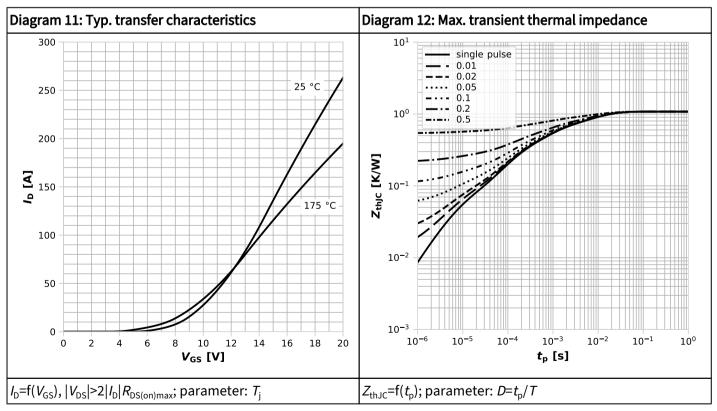




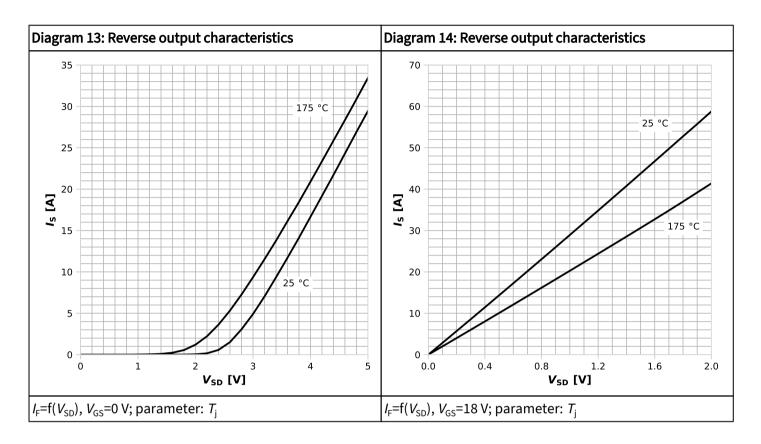


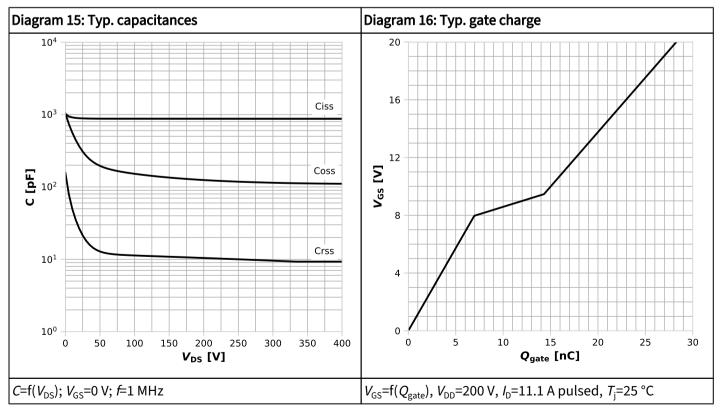




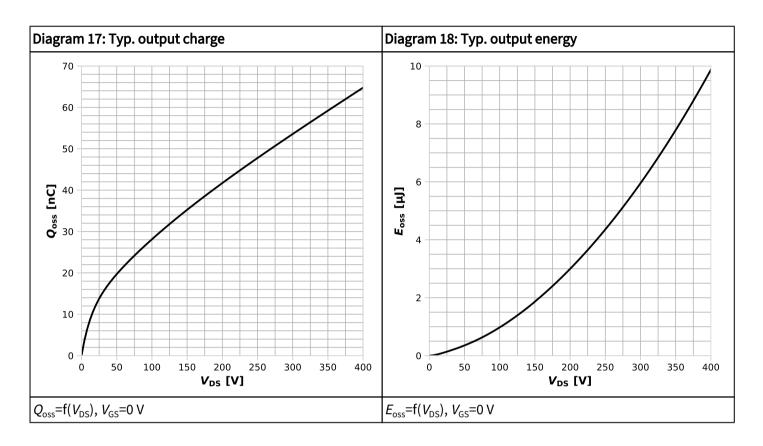


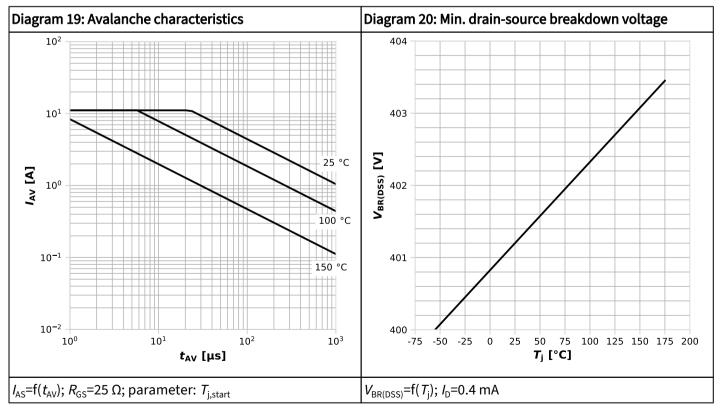




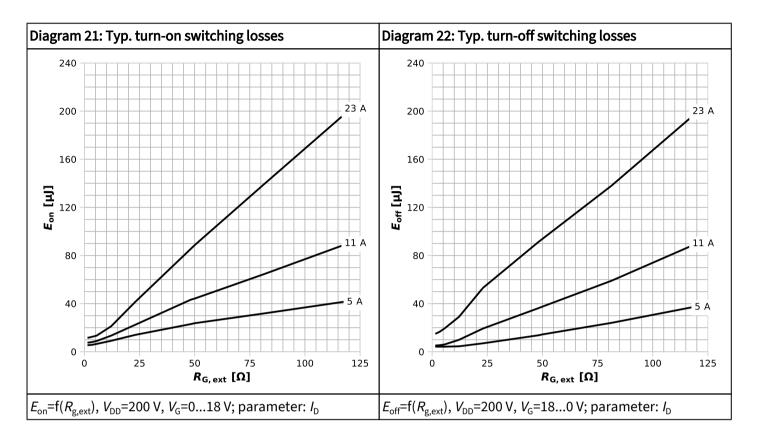


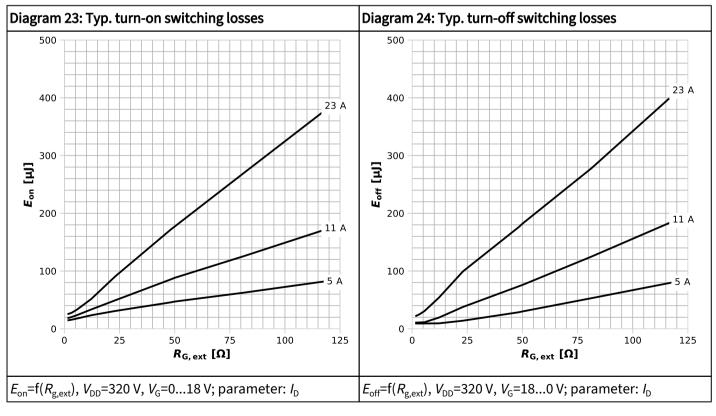














## 6 Test circuits

### Table 9 Switching times

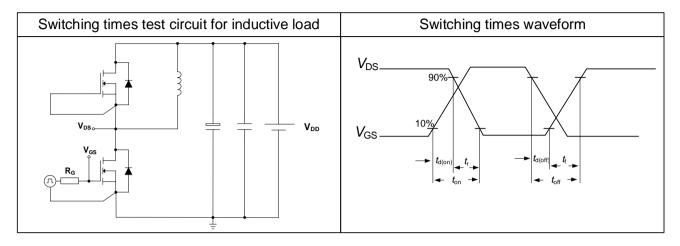
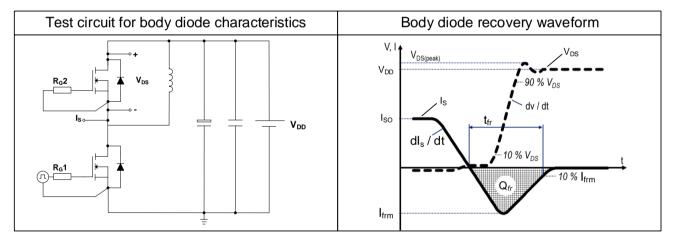
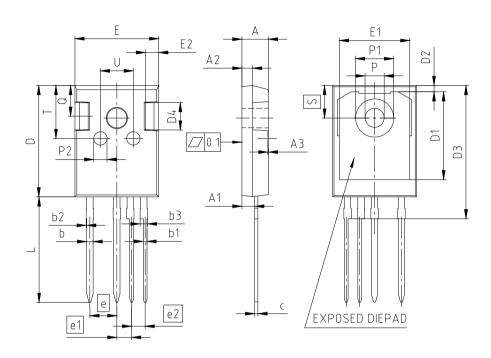


Table 10 Body diode characteristics





## 7 Package outlines

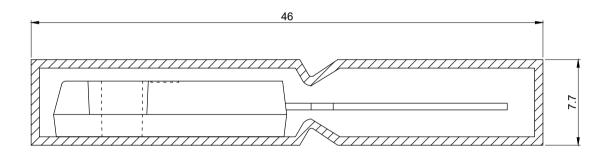


NOTES:
DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

PACKAGE - GROUP NUMBER:	PG-TO2	47-4-U02	]		
DIMENSIONS	MILLIM	ETERS	DIMENSIONS	MILLIM	ETERS
DIMENSIONS	MIN.	MAX.	DIMENSIONS	MIN.	MAX.
Α	4.90	5.10	E	15.70	15.90
A1	2.31	2.51	E1	13.10	13.50
A2	1.90	2.10	E2	2.40	2.60
A3	0.05	0.25	е	5.0	08
b	1.10	1.30	e1	2.79	
b1	0.65	0.79	e2	2.54	
b2		0.20	N	4	
b3	1.34	1.44	L	19.80	20.10
С	0.58	0.66	øΡ	3.50	3.70
D	20.90	21.10	øP1	7.00	7.40
D1	16.25	16.85	øP2	2.40	2.60
D2	1.05	1.35	Q	5.60	6.00
D3	24.97	25.27	S	6.	15
D4	4.90	5.10	Т	9.80	10.20
			U	6.00	6.40

Figure 1 Outline PG-TO247-4, dimensions in mm





All dimensions are in units mm
The drawing is in compliance with ISO 128-30, Projection Method 1 [→ ⊕]

Figure 2 Packaging variant PG-TO247-4, dimensions in mm

### **Public**

# 400V CoolSiC™ G2 MOSFET IMZA40R036M2H



## **Revision history**

IMZA40R036M2H

### Revision 2025-07-15, Rev. 1.0

**Previous revisions** 

Revision	Date	Subjects (major changes since last revision)
1.0	2025-07-15	Release of final datasheet

#### **Public**

# 400V CoolSiC™ G2 MOSFET IMZA40R036M2H



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